FORM	PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICATION NO. 10/074,584
OIP IN	FORMATION DISCLOSURE STATEMENT		
	BY APPLICANT	APPLICANT Todd et al.	
AUG 22 (USE SEVERAL SHEETS IF NECESSARY)	FILING DATE February 11, 2002	GROUP 2823
TRADE			

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
1. BU	5,214,002	05/25/93	Hayashi et al.			
2. PM	5,356,821	10/18/94	Naruse et al.			
3. By	5,471,330	11/28/95	Sarma			
4. BA	6,103,600	08/15/00	Ueda et al.			

FOREIGN PATENT DOCUMENTS							
EXAMINER	DOCUMENT NUMBER DA		COUNTRY	CLASS	SUBCLASS	TRANSLATION	
INITIAL						YES	NO
5. BU	11317530	16-11-99	Japan (abstract)			X	
6. BK	EP 0368651 A2	16-05-90					
· 7. Bu	EP 0486047 A2	20-05-92			·		-
8. Brl	EP 0747974 A2	11-12-96					
9. BK	EP 1065728 A2	03-01-01					
10.BU	GB 2332564 A	23-06-99	United Kingdom	_			

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
11. 184	Olivares, J. et al.; "Solid-phase crystallization of amorphous SiGe films deposited by LPCVD on SiO ₂ and glass," Thin Solid Films 337 (1999) pp. 51-54.

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EXAMINER FORON Kikedl	DATE CONSIDERED	4/28/2005
*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM	ON IS IN CONFORMANCE WITH WITH NEXT COMMUNICATION	H MPEP 609; DRAW LINE THROUGH CITATION IF NOT N TO APPLICANT.

JAH 3 1 WW L		PTO/SB/08 Equivalent
	Application No.	10/074,564
INFORMATION DISCESSURE	Filing Date	February 11, 2002
STATEMENT BY APPLICANT	First Named Inventor	Todd et al.
STATEMENT BY APPLICANT	Art Unit	2823
(Multiple sheets used when necessary)	Examiner	Brook Kebede
SHEET 1 OF 1	Attorney Docket No.	ASMEX.333A

	U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	
		5,959,326	09-28-1099	Aiso et al.		
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	FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹	
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		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹
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